Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/624,038	CHEN ET AL.
Examiner	Art Unit
Allan R. Wilson	2815

	SEARCHED				
Class	Subclass	Date	Examiner		
257	197	4/5/2006	AW		
257	200-201	4/5/2006	AW		
257	571, 586	4/5/2006	AW		
257	592, 623	4/5/2006	AW		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			:		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	4/5/2006	AW		